

FORM PTO-1449
(REV. 7-85)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

(Use only on sheets if necessary)



ATTY. DOC. NO.
QA0235 NP
APPLICATION NO.
10/000,389
APPLICANT
LAUNAY ET AL.
FILING DATE
NOVEMBER 30, 2001

1626
Sheet 1 of 2

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
SNW	AA 5,482,921	1/9/96	Seckinger et al.			
SNW	AB 5,605,877	2/25/97	Schafer et al.			
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLASS	TRANSLATION YES NO
SNW	AM JP5540653 ✓	3/22/80	Japan			<input type="checkbox"/> <input type="checkbox"/>
	AN WO94/05668 ✓	3/17/94	PCT			<input type="checkbox"/> <input type="checkbox"/>
	AO WO00/13508 ✓	6/1/00	PCT			<input type="checkbox"/> <input type="checkbox"/>
	AP WO01/07052 ✓	2/1/01	PCT			<input type="checkbox"/> <input type="checkbox"/>
SNW	AQ WO01/30781 ✓	5/3/01	PCT			<input type="checkbox"/> <input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.)

SNW	AR	Issartel et al.; Eur. J. Med. Chem., 31, pp. 717-723 (1996) ✓
SNW	AS	Winstead et al.; J. of Med. Chem. p. 142 (1966) ✓
SNW	AT	Nam et al.; Arch. Pharm. Pharm. Med. Chem. pp. 268 - 270 (1997) ✓

EXAMINER

DATE CONSIDERED

Donya Wright

9-5-02

*EXAMINER: Initial of reference considered, whether or not citation is in conformance with MPEP 609: Draw a line through citation if not in conformance and not considered. Include a copy of this form with the next communication to applicant.

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ATTY. DOCKET NO.
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Sheet 2 of 2

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	AA					
	AB					
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	AJ					
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	AL					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLASS	TRANSLATION YES NO	
<i>AMW</i>	AM EP0272594 ✓	6/29/88	Europe			<input type="checkbox"/>	<input type="checkbox"/>
	AN EP1004583 ✓	5/31/00	Europe			<input type="checkbox"/>	<input type="checkbox"/>
	AO WO98/39303 ✓	9/11/98	PCT			<input type="checkbox"/>	<input type="checkbox"/>
<i>AMW</i>	AP AU-A-82875/87 ✓	6/23/88	Australia			<input type="checkbox"/>	<input type="checkbox"/>
	AQ					<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.)

<i>AMW</i>	AR	Corey et al.; J. of the Am. Chemical Society, 92:8, pp. 2476 - 2480 (1970) ✓
	AS	
	AT	

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DATE CONSIDERED

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FORM PTO-149
(REV. 7-85)U.S. DEPARTMENT OF COMMERCE
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INFORMATION DISCLOSURE CITATION

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	OFFICE	CLASS	SUBCLASS	TRANSLATION YES NO	
<i>SNW</i>	AM WO02/08227A2	1/31/02	PCT			<input type="checkbox"/>	<input type="checkbox"/>
<i>SNW</i>	AN DE2354086	5/16/74	German			<input type="checkbox"/>	<input checked="" type="checkbox"/>
<i>SNW</i>	AO WO98/08813	3/5/98	PCT			<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
	AQ					<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.)

<i>SNW</i>	AR	Abstract, XP-002196369, ComGenex Product List, Am. Chem. Soc.; 1999
<i>SNW</i>	AS	Abstract, XP-002196370, ComGenex Product List, Am. Chem. Soc.; 1999
<i>SNW</i>	AT	Abstract, XP-002196371, ComGenex Product List, Am. Chem. Soc.; 1999

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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent pages, Etc.)

AA	Abstract, XP-002196372, ComGenex Product List, Am. Chem. Soc.; 1999	/
AB	Abstract, XP-002196373, ComGenex Product List, Am. Chem. Soc.; 1999	/
AC	Abstract, XP-002196374, ComGenex Product List, Am. Chem. Soc.; 1999	/
AD	Abstract, XP-002196375, ComGenex Product List, Am. Chem. Soc.; 1999	/
AE	Abstract, XP-002196376, ComGenex Product List, Am. Chem. Soc.; 1999	/
AF	Abstract, XP-002196377, ComGenex Product List, Am. Chem. Soc.; 1999	/
AG	Abstract, XP-002196368, Chem. Abstracts Service, Vol 101, No. 110818, 1984	/
AH	Migawa et al. Organic Letters, Vol 2, No. 21, pp. 3309 - 3311, 2000	/
AI	Deprez et al., Tetrahedron: Asymmetry, Vol. 2, No. 12, pp. 1189 - 1192, 1991	/
AJ	Wittland, et al. Synthesis (11), pp. 1291- 1295 , 1997	/
AK	Deprez et al., Tetrahedron Vol. 49, No. 18, pp. 3781 - 3792, 1993	/
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AM		
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